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Renesas Technology Corp.
Customer Support Dept.
April 1, 2003

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Keep safety first in your circuit designs!

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2SK3287

Silicon N Channel MOS FET High Speed Switching

RENESAS

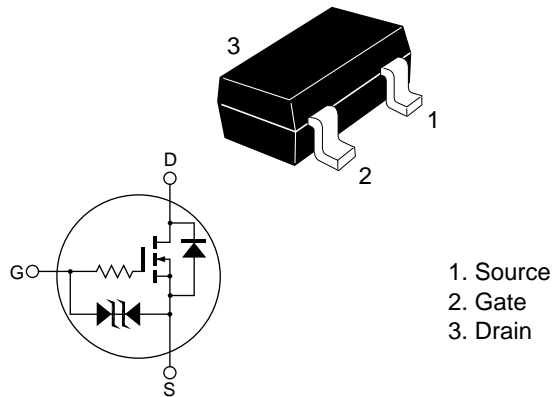
ADE-208-742 C (Z)
4th.Edition.
June 1999

Features

- Low on-resistance
 $R_{DS} = 1.26 \Omega$ typ. ($V_{GS} = 10 \text{ V}$, $I_D = 150 \text{ mA}$)
 $R_{DS} = 2.8 \Omega$ typ. ($V_{GS} = 4 \text{ V}$, $I_D = 50 \text{ mA}$)
- 4 V gate drive device.
- Small package (MPAK)

Outline

MPAK



Absolute Maximum Ratings (Ta = 25°C)

| Item | Symbol | Ratings | Unit |
|--|----------------------------------|-------------|------|
| Drain to source voltage | V_{DSS} | 30 | V |
| Gate to source voltage | V_{GSS} | ±20 | V |
| Drain current | I_D | 300 | mA |
| Drain peak current | $I_{D(pulse)}$ ^{Note 1} | 1.2 | A |
| Body-drain diode reverse drain current | I_{DR} | 300 | mA |
| Channel dissipation | Pch ^{Note 2} | 400 | mW |
| Channel temperature | Tch | 150 | °C |
| Storage temperature | Tstg | -55 to +150 | °C |

Note: 1. PW ≤ 10 μs, duty cycle ≤ 1%

2. Value on the alumina ceramic board (12.5 x 20 x 0.7 mm)

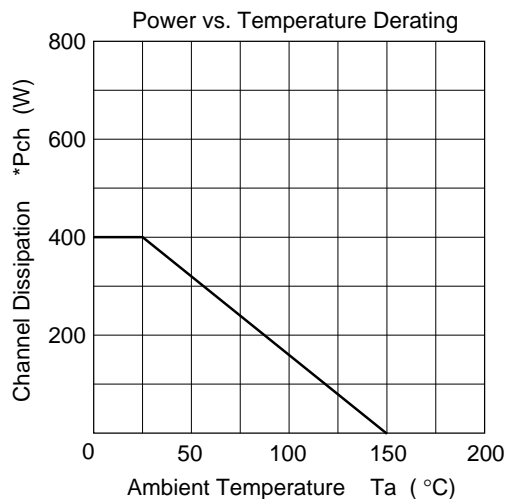
Electrical Characteristics (Ta = 25°C)

| Item | Symbol | Min | Typ | Max | Unit | Test Conditions |
|--|---------------|-----|------|------|------|---|
| Drain to source breakdown voltage | $V_{(BR)DSS}$ | 30 | — | — | V | $I_D = 100 \mu A, V_{GS} = 0$ |
| Gate to source breakdown voltage | $V_{(BR)GSS}$ | ±20 | — | — | V | $I_G = \pm 100 \mu A, V_{DS} = 0$ |
| Gate to source leak current | I_{GSS} | — | — | ±5 | μA | $V_{GS} = \pm 16 V, V_{DS} = 0$ |
| Zero gate voltage drain current | I_{DSS} | — | — | 1 | μA | $V_{DS} = 30 V, V_{GS} = 0$ |
| Gate to source cutoff voltage | $V_{GS(off)}$ | 1.3 | — | 2.3 | V | $I_D = 10 \mu A, V_{DS} = 5 V$ |
| Static drain to source on state resistance | $R_{DS(on)}$ | — | 1.26 | 1.44 | Ω | $I_D = 150 mA, V_{GS} = 10 V$ ^{Note 3} |
| | $R_{DS(on)}$ | — | 2.8 | 3.44 | Ω | $I_D = 50 mA, V_{GS} = 4 V$ ^{Note 3} |
| Forward transfer admittance | $ y_{fs} $ | 145 | 220 | — | mS | $I_D = 150 mA, V_{DS} = 10 V$ ^{Note 3} |
| Input capacitance | Ciss | — | 6 | — | pF | $V_{DS} = 10 V$ |
| Output capacitance | Coss | — | 18 | — | pF | $V_{GS} = 0$ |
| Reverse transfer capacitance | Crss | — | 2 | — | pF | f = 1 MHz |
| Turn-on delay time | $t_{d(on)}$ | — | 200 | — | ns | $I_D = 150 mA, V_{GS} = 10 V$ |
| Rise time | t_r | — | 600 | — | ns | $R_L = 66.6 \Omega$ |
| Turn-off delay time | $t_{d(off)}$ | — | 1100 | — | ns | |
| Fall time | t_f | — | 1100 | — | ns | |

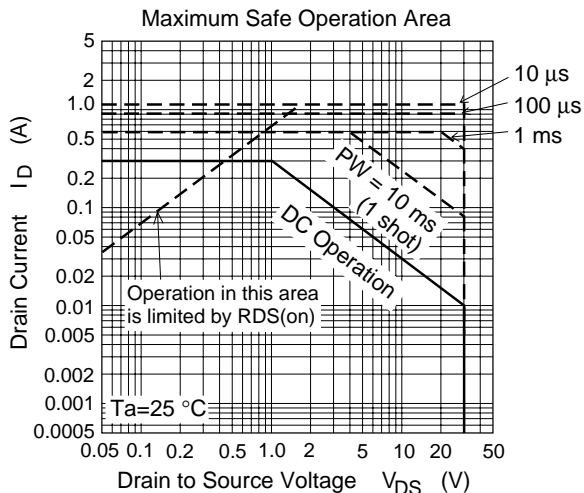
Note: 3. Pulse test

4. Marking is AN

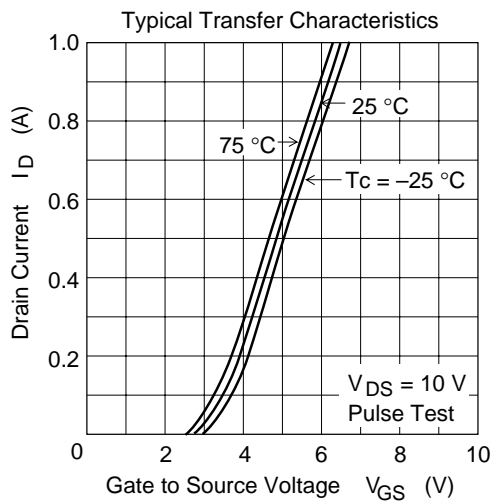
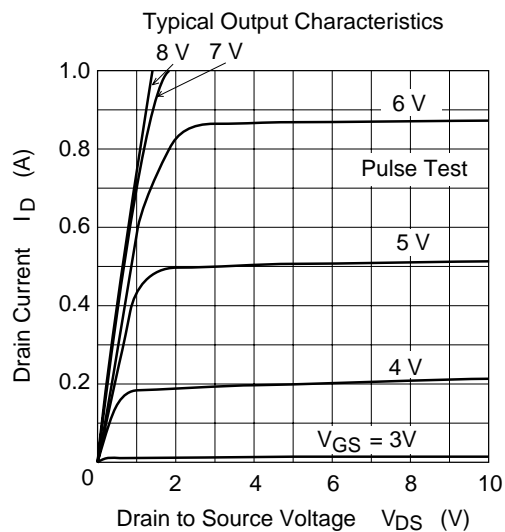
Main Characteristics

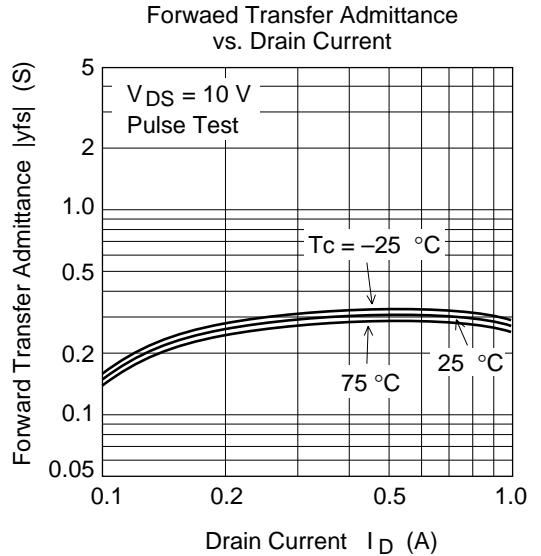
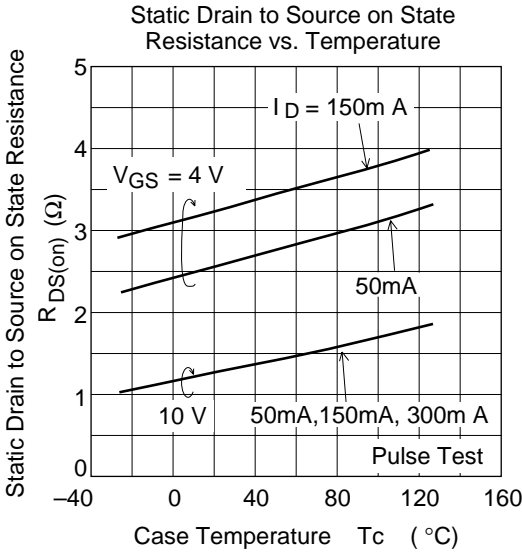
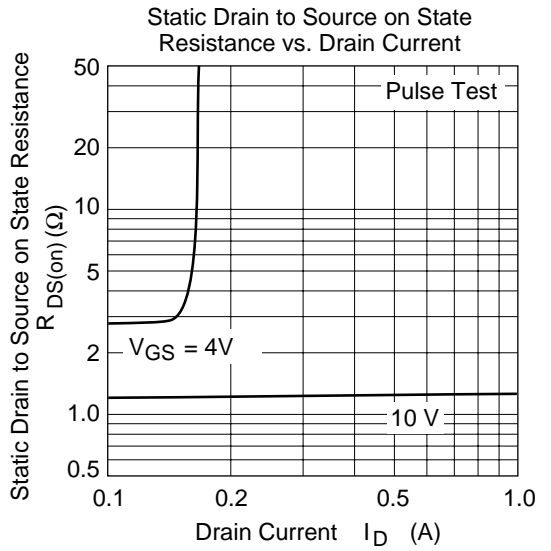
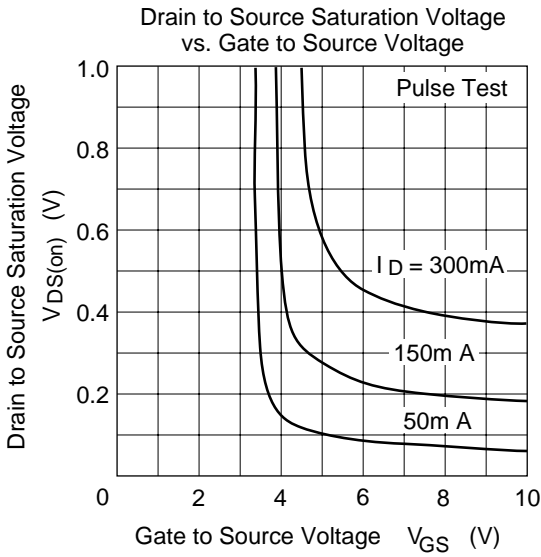


*Value on the alumina ceramic board.(12.5x20x0.7mm)

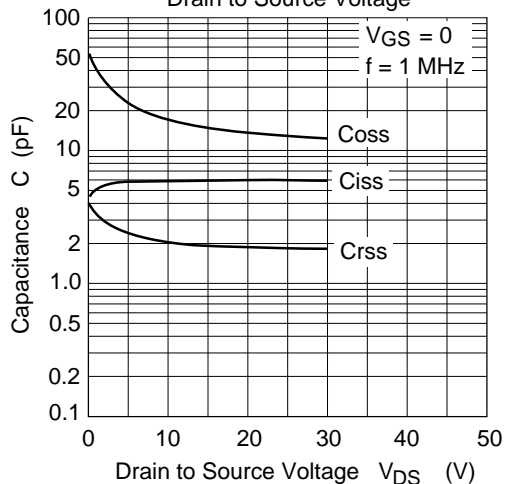


Value on the alumina ceramic board.(12.5x20x0.7mm)

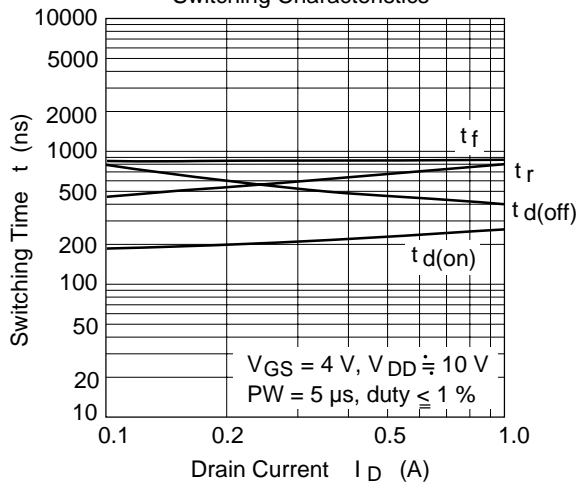




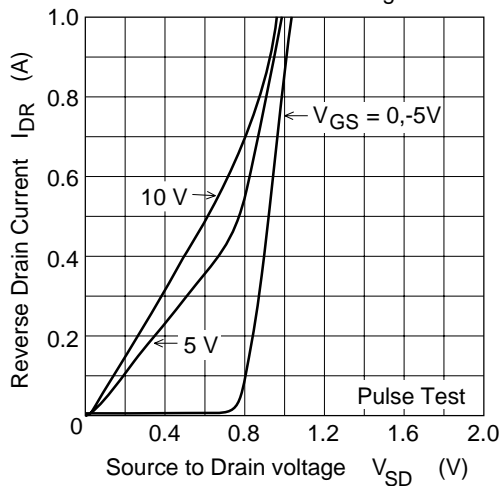
Typical Capacitance vs. Drain to Source Voltage



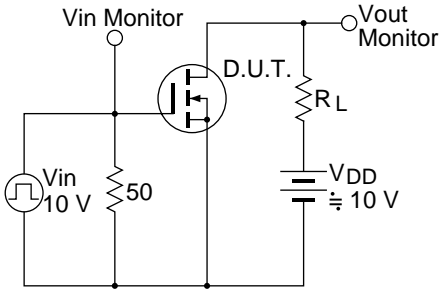
Switching Characteristics



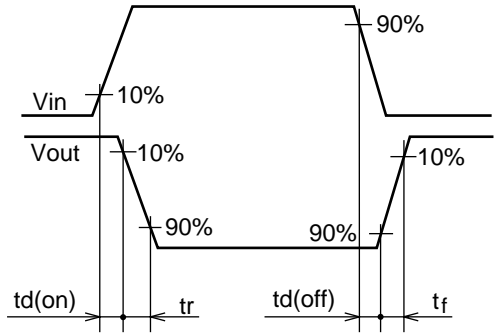
Reverse Drain Current vs. Source to Drain Voltage



Switching Time Test Circuit



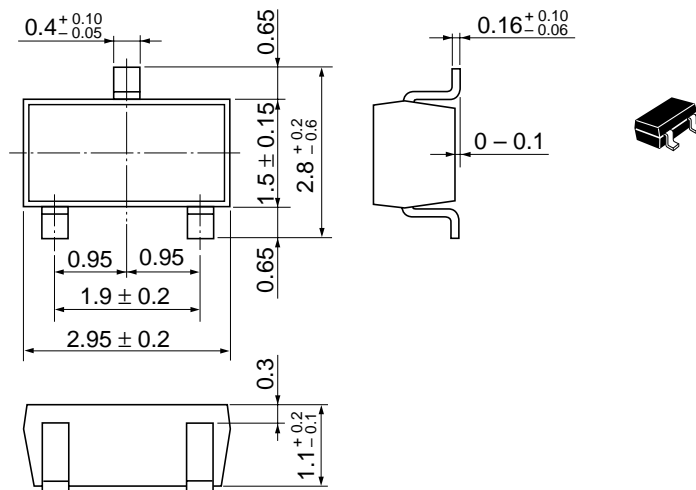
Waveforms



Package Dimensions

As of January, 2001

Unit: mm



| | |
|------------------------|----------|
| Hitachi Code | MPAK |
| JEDEC | — |
| EIAJ | Conforms |
| Mass (reference value) | 0.011 g |

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